

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOSIV)

# TPCS8303

Lithium Ion Battery Applications  
 Notebook PC Applications  
 Portable Machines and Tools

- Small footprint due to small and thin package
- Low drain-source ON resistance:  $R_{DS(ON)} = 15 \text{ m}\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 18 \text{ S}$  (typ.)
- Low leakage current:  $I_{DSS} = -10 \text{ }\mu\text{A}$  (max) ( $V_{DS} = -20 \text{ V}$ )
- Enhancement mode:  $V_{th} = -0.45 \sim -1.2 \text{ V}$  ( $V_{DS} = -10 \text{ V}$ ,  $I_D = -200 \text{ }\mu\text{A}$ )

## Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

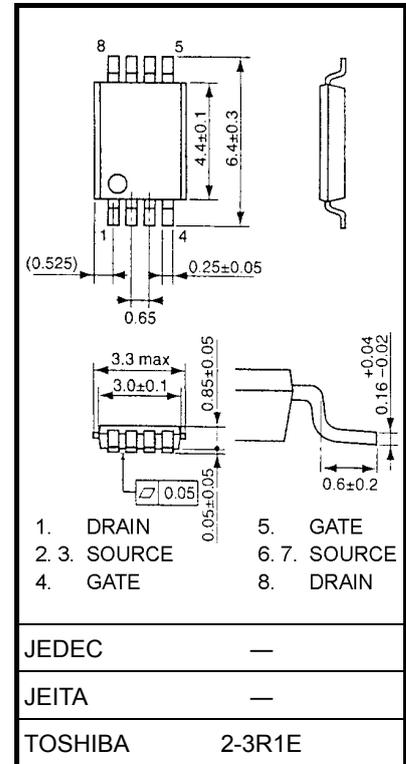
| Characteristics   |   | Symbol    | Rating   | Unit             |
|---|---|-----------|----------|------------------|
| Drain-source voltage  |   | $V_{DSS}$ | -20      | V                |
| Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )                                  |   | $V_{DGR}$ | -20      | V                |
| Gate-source voltage   |   | $V_{GSS}$ | $\pm 12$ | V                |
| Drain current   | DC (Note 1)                                     | $I_D$     | -5       | A                |
|   | Pulse (Note 1)                                  | $I_{DP}$  | -20      |                  |
| Drain power dissipation ( $t = 10 \text{ s}$ ) (Note 2a)                              | Single-device operation (Note 3a)               | $P_D(1)$  | 1.1      | W                |
|   | Single-device value at dual operation (Note 3b) | $P_D(2)$  | 0.75     |                  |
| Drain power dissipation ( $t = 10 \text{ s}$ ) (Note 2b)                              | Single-device operation (Note 3a)               | $P_D(1)$  | 0.6      | W                |
|   | Single-device value at dual operation (Note 3b) | $P_D(2)$  | 0.35     |                  |
| Single pulse avalanche energy (Note 4)  |   | $E_{AS}$  | 16.3     | mJ               |
| Avalanche current   |   | $I_{AR}$  | -5       | A                |
| Repetitive avalanche energy<br>Single-device value at dual operation (Note 2a, 3b, 5) |   | $E_{AR}$  | 0.075    | mJ               |
| Channel temperature   |   | $T_{ch}$  | 150      | $^\circ\text{C}$ |
| Storage temperature range   |   | $T_{stg}$ | -55~150  | $^\circ\text{C}$ |

Note: (Note 1), (Note 2), (Note 3), (Note 4), (Note 5): See the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

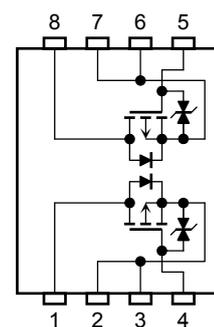
This transistor is an electrostatic-sensitive device. Please handle with caution.

Unit: mm



Weight: 0.035 g (typ.)

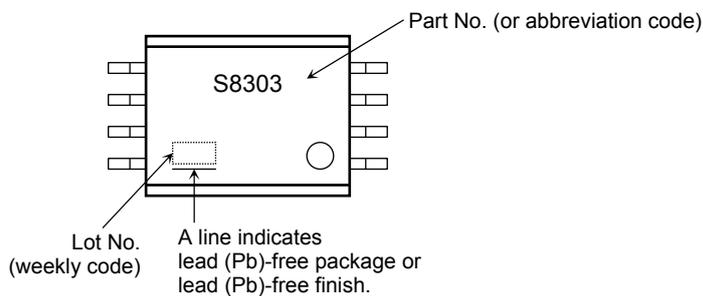
## Circuit Configuration



## Thermal Characteristics

| Characteristics                                      |   | Symbol            | Max | Unit |
|--|---|-------------------|-----|------|
| Thermal resistance, channel to ambient<br>(t = 10 s) | Single-device operation<br>(Note 3a)                  | $R_{th(ch-a)}(1)$ | 114 | °C/W |
|  | Single-device value at<br>dual operation<br>(Note 3b) | $R_{th(ch-a)}(2)$ | 167 |      |
| Thermal resistance, channel to ambient<br>(t = 10 s) | Single-device operation<br>(Note 3a)                  | $R_{th(ch-a)}(1)$ | 208 | °C/W |
|  | Single-device value at<br>dual operation<br>(Note 3b) | $R_{th(ch-a)}(2)$ | 357 |      |

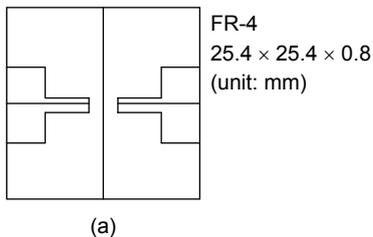
## Marking (Note 6)



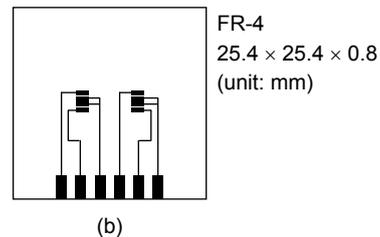
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:

a) Device mounted on a glass-epoxy board (a)



b) Device mounted on a glass-epoxy board (b)



Note 3:

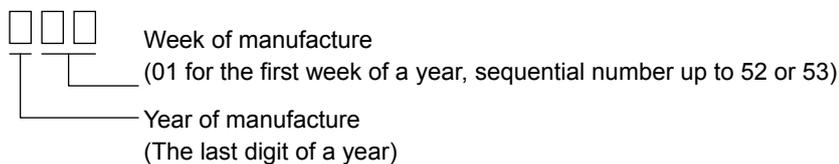
- The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.)
- The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.)

Note 4:  $V_{DD} = -16\text{ V}$ ,  $T_{ch} = 25^\circ\text{C}$ ,  $L = 500\ \mu\text{H}$ ,  $I_{AR} = -5\text{A}$ ,  $R_G = 25\ \Omega$

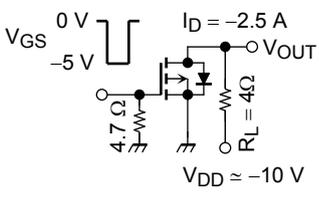
Note 5: Repetitive rating: pulse width limited by max channel temperature

Note 6:  $\circ$  on lower right of the marking indicates Pin 1.

※ Weekly code: (Three digits)

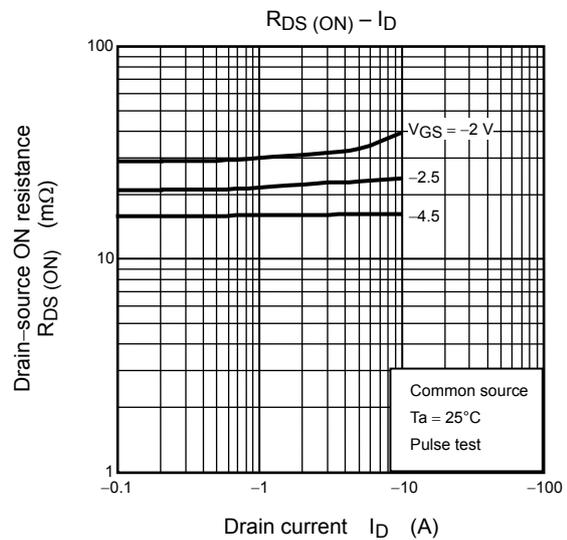
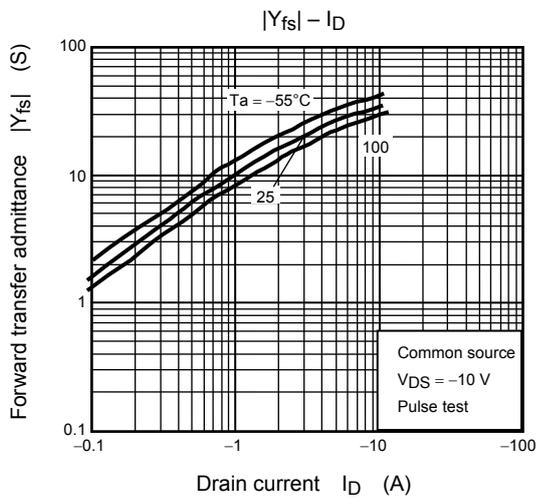
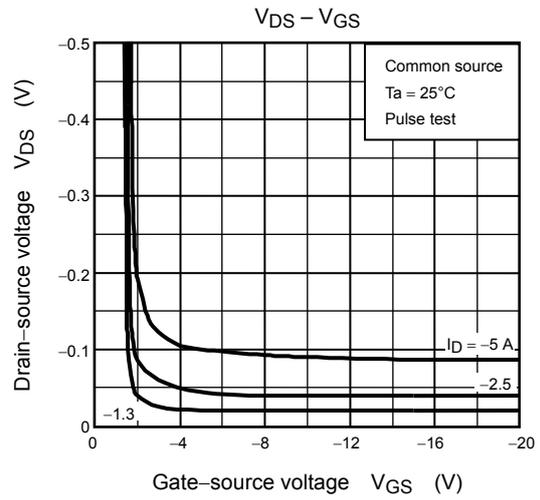
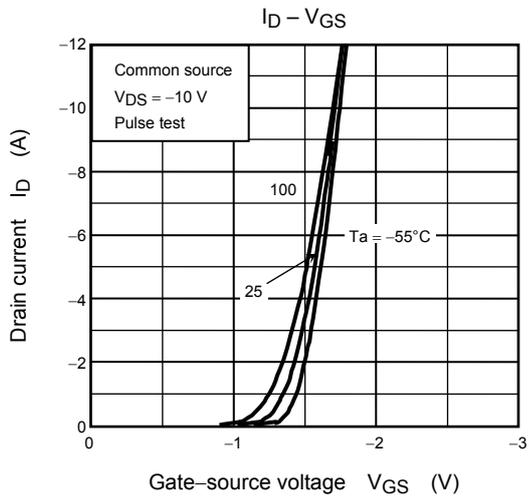
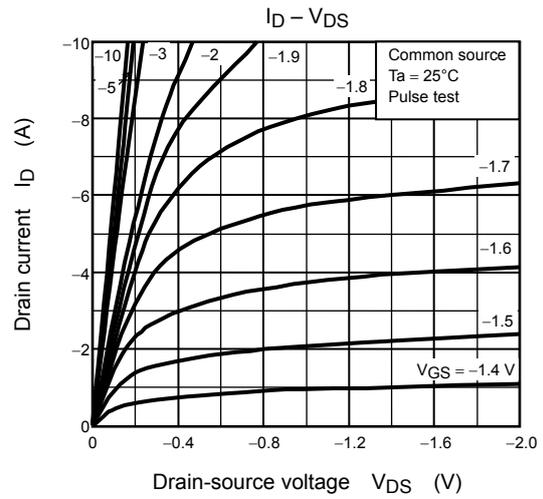
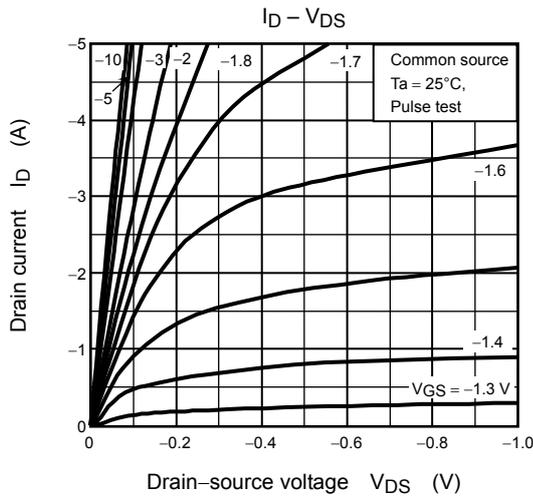


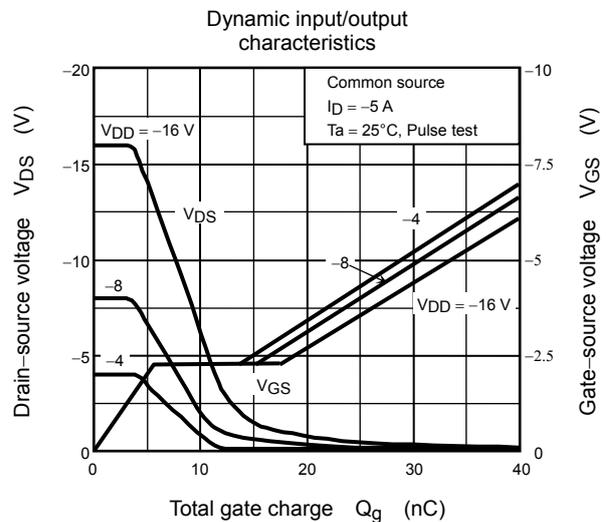
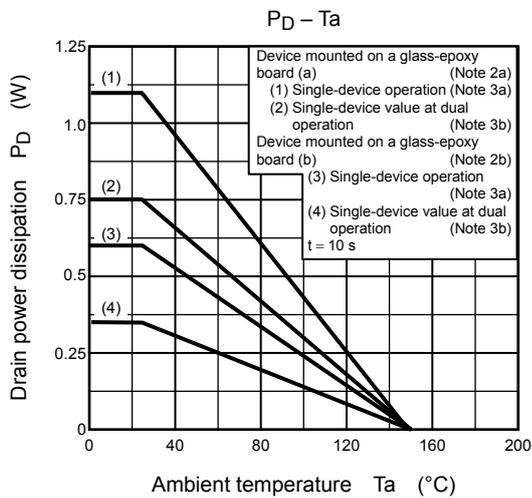
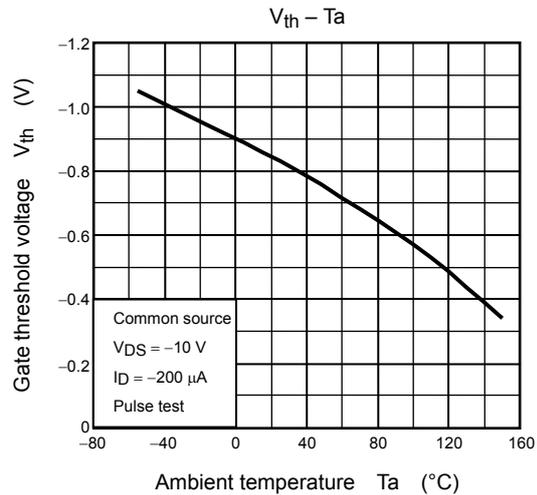
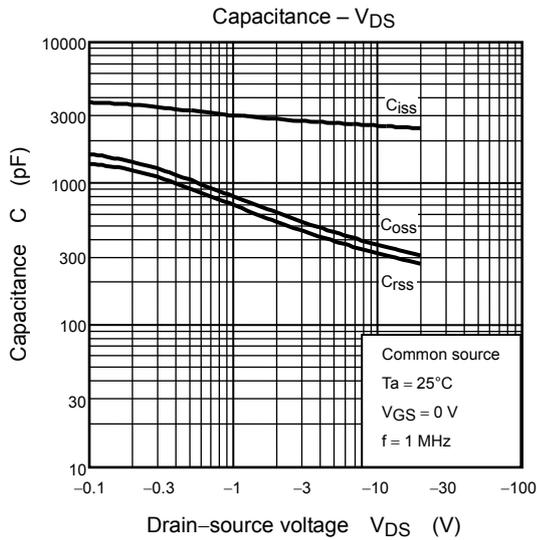
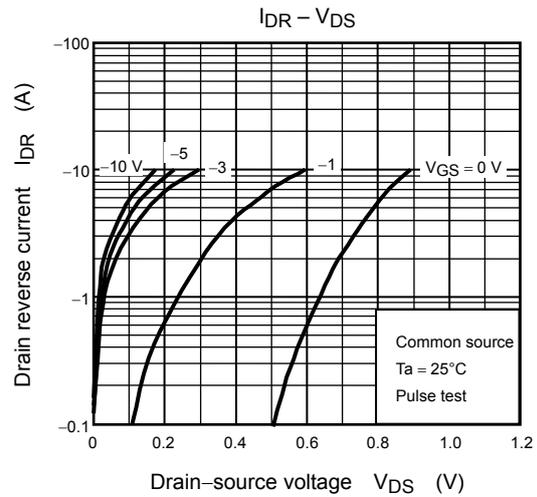
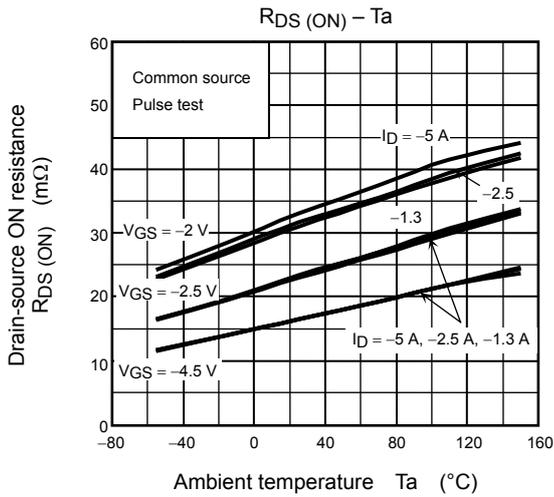
## Electrical Characteristics (Ta = 25°C)

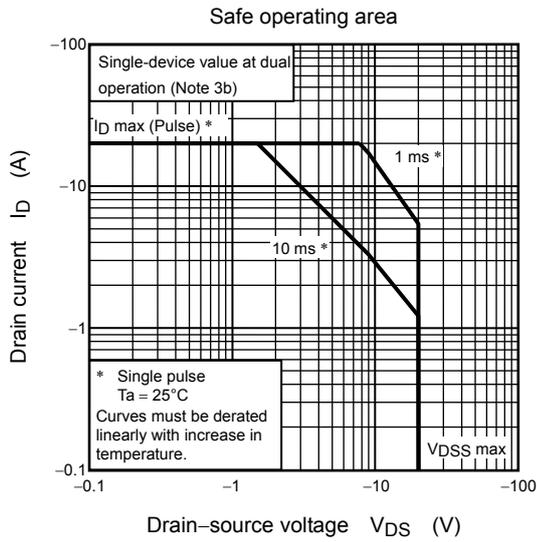
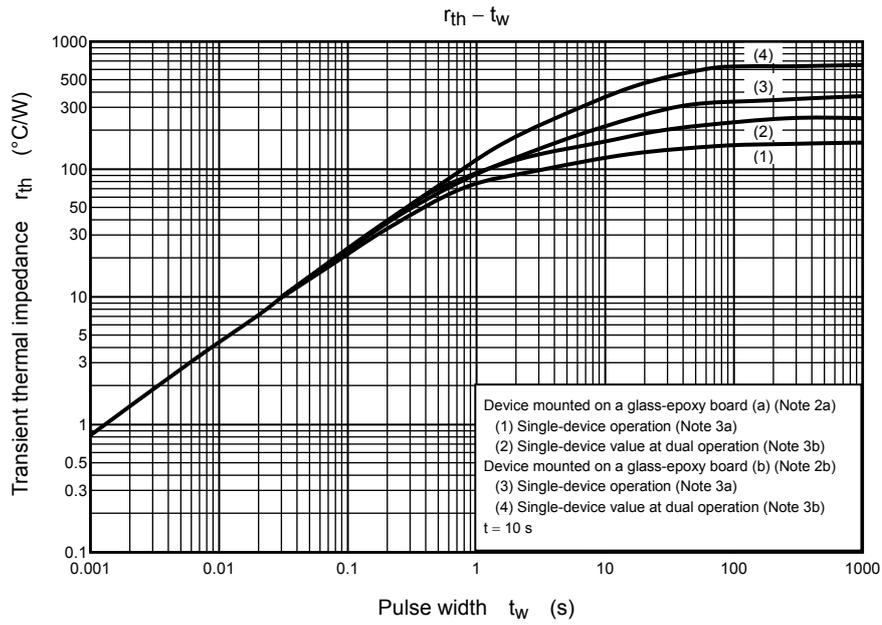
| Characteristics                                 |               | Symbol        | Test Condition   | Min   | Typ. | Max      | Unit          |
|---|---------------|---------------|--|-------|------|----------|---------------|
| Gate leakage current                            |               | $I_{GSS}$     | $V_{GS} = \pm 10\text{ V}, V_{DS} = 0\text{ V}$  | —     | —    | $\pm 10$ | $\mu\text{A}$ |
| Drain cut-OFF current                           |               | $I_{DSS}$     | $V_{DS} = -20\text{ V}, V_{GS} = 0\text{ V}$   | —     | —    | -10      | $\mu\text{A}$ |
| Drain-source breakdown voltage                  |               | $V_{(BR)DSS}$ | $I_D = -10\text{ mA}, V_{GS} = 0\text{ V}$   | -20   | —    | —        | V             |
|   |               | $V_{(BR)DSX}$ | $I_D = -10\text{ mA}, V_{GS} = 12\text{ V}$  | -8    | —    | —        |               |
| Gate threshold voltage                          |               | $V_{th}$      | $V_{DS} = -10\text{ V}, I_D = -200\text{ }\mu\text{A}$   | -0.45 | —    | -1.2     | V             |
| Drain-source ON resistance                      |               | $R_{DS(ON)}$  | $V_{GS} = -2.0\text{ V}, I_D = -2.5\text{ A}$  | —     | 31   | 80       | m $\Omega$    |
|   |               |               | $V_{GS} = -2.5\text{ V}, I_D = -2.5\text{ A}$  | —     | 22   | 30       |               |
|   |               |               | $V_{GS} = -4.5\text{ V}, I_D = -2.5\text{ A}$  | —     | 15   | 21       |               |
| Forward transfer admittance                     |               | $ Y_{fs} $    | $V_{DS} = -10\text{ V}, I_D = -2.5\text{ A}$   | 9     | 18   | —        | S             |
| Input capacitance                               |               | $C_{iss}$     | $V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$   | —     | 2560 | —        | pF            |
| Reverse transfer capacitance                    |               | $C_{rss}$     |  | —     | 330  | —        |               |
| Output capacitance                              |               | $C_{oss}$     |  | —     | 380  | —        |               |
| Switching time                                  | Rise time     | $t_r$         |  <p><math>V_{GS} = 0\text{ V}</math><br/><math>V_{GS} = -5\text{ V}</math><br/><math>I_D = -2.5\text{ A}</math><br/><math>V_{OUT}</math><br/><math>R_L = 4\Omega</math><br/><math>V_{DD} \approx -10\text{ V}</math><br/>Duty <math>\leq 1\%</math>, <math>t_w = 10\text{ }\mu\text{s}</math></p> | —     | 5    | —        | ns            |
|   | Turn-ON time  | $t_{on}$      |  | —     | 14   | —        |               |
|   | Fall time     | $t_f$         |  | —     | 42   | —        |               |
|   | Turn-OFF time | $t_{off}$     |  | —     | 142  | —        |               |
| Total gate charge (gate-source plus gate-drain) |               | $Q_g$         | $V_{DD} \approx -16\text{ V}, V_{GS} = -5\text{ V}, I_D = -5\text{ A}$   | —     | 33   | —        | nC            |
| Gate-source charge 1                            |               | $Q_{gs}$      |  | —     | 10   | —        |               |
| Gate-drain ("miller") charge                    |               | $Q_{gd}$      |  | —     | 5.4  | —        |               |

## Source-Drain Ratings and Characteristics (Ta = 25°C)

| Characteristics         |                | Symbol    | Test Condition                              | Min | Typ. | Max | Unit |
|-------------------------|----------------|-----------|---|-----|------|-----|------|
| Drain reverse current   | Pulse (Note 1) | $I_{DRP}$ | —   | —   | —    | -20 | A    |
| Forward voltage (diode) |                | $V_{DSF}$ | $I_{DR} = -5\text{ A}, V_{GS} = 0\text{ V}$ | —   | —    | 1.2 | V    |







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